

# **HEXFET® Chip-Set for DC-DC Converters**

- N Channel Application Specific MOSFETs
- Ideal for Mobile DC-DC Converters
- Low Conduction Losses
- Low Switching Losses
- Lead-Free

# 



## Description

This new device employs advanced HEXFET Power MOSFET technology to achieve an unprecedented balance of on-resistance and gate charge. The reduced conduction and switching losses make this device ideal for high efficiency DC-DC Converters that power the latest generation of mobile microprocessors.

The IRF7805PbF offers maximum efficiency for mobile CPU core DC-DC converters.

## **Devices Features**

	IRF7805PbF
V <sub>DSS</sub>	30V
R <sub>DS(on)</sub>	11mΩ
Qg	31nC
Q <sub>sw</sub>	11.5nC
Qoss	36nC

G	D	S
Gate	Drain	Source

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Base part number	Package Type	Form	Quantity	Orderable Part Number
IRF7805PbF	SO-8	Tape and Reel	4000	IRF7805PbF

Symbol	Parameter	Max.	Units	
V <sub>DS</sub> Drain-Source Voltage		30	.,	
$V_{GS}$	Gate-to-Source Voltage	± 12	V	
I <sub>D</sub> @ T <sub>A</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V ③	13		
I <sub>D</sub> @ T <sub>A</sub> = 70°C	Continuous Drain Current, V <sub>GS</sub> @ 10V ③	10	Α	
I <sub>DM</sub>	Pulsed Drain Current ①	100		
P <sub>D</sub> @T <sub>A</sub> = 25°C	Maximum Power Dissipation ③	2.5	10/	
P <sub>D</sub> @T <sub>A</sub> = 70°C	Maximum Power Dissipation ③	1.6	W	
	Linear Derating Factor	0.02	W/°C	
$T_J$	Operating Junction and	-55 to + 150	°C	
$T_{STG}$	Storage Temperature Range			

#### **Thermal Resistance**

Symbol	bol Parameter		Max.	Units
$R_{ heta JL}$	Junction-to-Drain Lead®		20	°C // //
$R_{\theta JA}$	Junction-to-Ambient ③		50	°C/W



# Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage ®	30			V	$V_{GS} = 0V, I_D = 250\mu A$
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance ©		9.2	11	mΩ	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 7.0A ②
$V_{GS(th)}$	Gate Threshold Voltage ®	1.0		3.0	V	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$
I <sub>DSS</sub>				70		$V_{DS} = 30V, V_{GS} = 0V$
	Drain-to-Source Leakage Current			10	μΑ	$V_{DS} = 24V, V_{GS} = 0V$
				150		$V_{DS} = 24V, V_{GS} = 0V, T_{J} = 100^{\circ}C$
	Gate-to-Source Forward Leakage			100	- Λ	$V_{GS} = 12V$
I <sub>GSS</sub>	Gate-to-Source Reverse Leakage			-100	nA	$V_{GS} = -12V$

# Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

$Q_g$	Total Gate Charge ©		22	31		
$Q_{gs1}$	Pre -Vth Gate-to-Source Charge		3.7			V <sub>GS</sub> = 5.0V
$Q_{gs2}$	Post-Vth Gate-to-Source Charge		1.4		nC	V <sub>DS</sub> = 16V
$Q_{gd}$	Gate-to-Drain Charge		6.8			$I_{D} = 7.0A$
$Q_{sw}$	Switch Charge (Qgs2 + Qgd) ®		8.2	11.5		
$Q_{oss}$	Output Charge ©		30	36	nC	$V_{DS} = 16V, V_{GS} = 0V$
$R_G$	Gate Resistance	0.5		1.7	Ω	
$t_{d(on)}$	Turn-On Delay Time		16			V <sub>DD</sub> = 16V,V <sub>GS</sub> = 4.5V ②
t <sub>r</sub>	Rise Time	_	20		no	$I_{D} = 7.0A$
$t_{d(off)}$	Turn-Off Delay Time		38		ns	$R_G = 2\Omega$
t <sub>f</sub>	Fall Time		16			Resistive Load

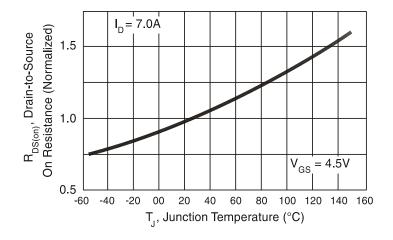
### **Diode Characteristics**

	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current (Body Diode)①			2.5		MOSFET symbol showing the
I <sub>SM</sub>	Pulsed Source Current (Body Diode)			106		integral reverse p-n junction diode.
$V_{SD}$	Diode Forward Voltage®			1.2	V	$T_J = 25^{\circ}C, I_S = 7.0A, V_{GS} = 0V$
Q <sub>rr</sub>	Reverse Recovery Charge ④		88			di/dt = $700A/\mu s$ V <sub>DS</sub> = $16V$ , V <sub>GS</sub> = $0V$ , I <sub>S</sub> = $7.0A$
Q <sub>rr</sub>	Reverse Recovery Charge ®		55			di/dt = 700A/μs (with 10BQ040) V <sub>DS</sub> =16V, V <sub>GS</sub> = 0V, I <sub>S</sub> = 7.0A

#### Notes:

- $\, \oplus \,$  Repetitive rating; pulse width limited by max. junction temperature.
- ② Pulse width  $\leq 300 \mu s$ ; duty cycle  $\leq 2\%$ .
- ④ Typ = measured Q<sub>OSS</sub>
- ©  $R_{\theta}$  is measured at  $T_J$  of approximately 90°C.
- © Devices are 100% tested to these parameters.





**Fig. 1** Normalized On-Resistance vs. Temperature

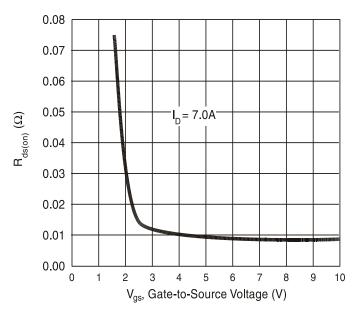
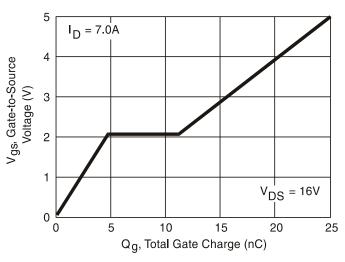


Fig. 3 Typical Rds(on) vs. Gate-to-Source Voltage



**Fig. 2** Typical Gate Charge vs. Gate-to-Source Voltage

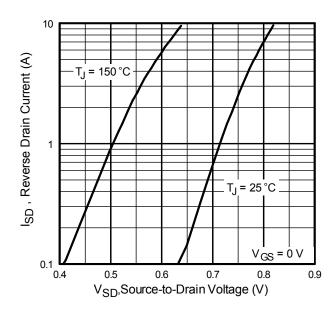


Fig. 4 Typical Source-Drain Diode Forward Voltage

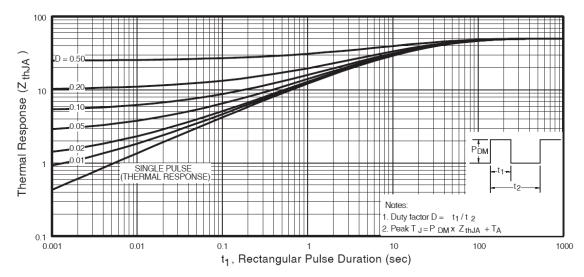
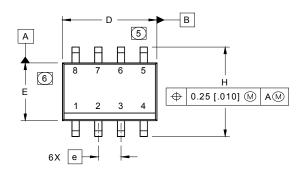


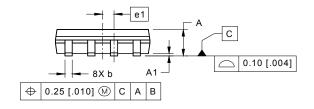
Fig 5. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

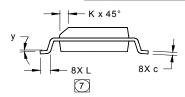


# **SO-8 Package Outline** (Dimensions are shown in millimeters (inches)

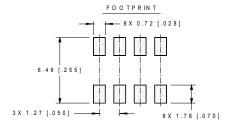


DIM	INC	HES	MILLIM	ETERS
DIIVI	MIN	MAX	MIN	MAX
Α	.0532	.0688	1.35	1.75
A1	.0040	.0098	0.10	0.25
b	.013	.020	0.33	0.51
С	.0075	.0098	0.19	0.25
D	.189	.1968	4.80	5.00
Е	.1497	.1574	3.80	4.00
е	.050 BASIC		1.27 BASIC	
e 1	.025 B	ASIC	0.635 E	BASIC
Н	.2284	.2440	5.80	6.20
K	.0099	.0196	0.25	0.50
L	.016	.050	0.40	1.27
у	0°	8°	0°	8°



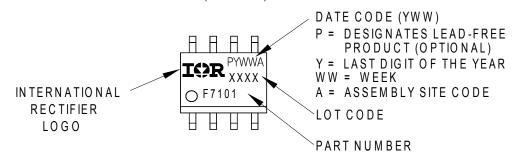


- 1. DIMENSIONING & TOLERANCING PER ASME Y14.5M -1994
- C O N TR O LLIN G D IM EN SION: MILLIMETER
- DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES]. OUTLINE CONFORMS TO JEDEC OUTLINE MS-012AA
- [5] DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS MOLD PROTRUSIONS NOT TO EXCEED 0.15 [.006].
- 6 DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS MOLD PROTRUSIONS NOT TO EXCEED 0.25 [.010].
- 7 DIMENSION IS THE LENGTH OF LEAD FOR SOLDERING TO A SUBSTRATE.



# **SO-8 Part Marking Information**

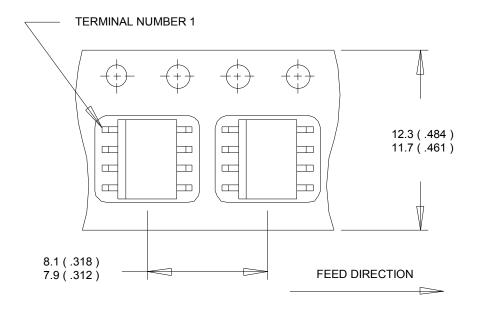
## EXAMPLE: THIS IS AN IRF7101 (MOSFET)



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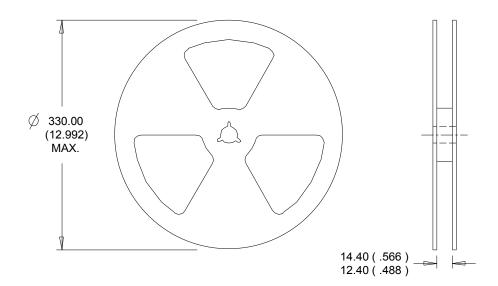


## SO-8 Tape and Reel (Dimensions are shown in millimeters (inches)



#### NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



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2016-8-23



#### **Qualification Information**

Qualification Level	Consumer				
Moisture Sensitivity Level	SO-8 MSL1 (per JEDEC J-STD-020D) <sup>†</sup>				
RoHS Compliant	Yes				

<sup>†</sup> Applicable version of JEDEC standard at the time of product release.

### **Revision History**

Date	Comments			
08/23/2016	<ul> <li>Changed datasheet with Infineon logo - all pages.</li> <li>Corrected typo Qoss from typ/max "3.0nC/3.6nC" to "30nC/36nC" on page 2.</li> <li>Added disclaimer on last page.</li> </ul>			

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